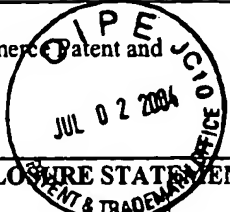


07/02/04

FORM PTO-1449 U.S. Department of Commerce Patent and Trademark Office		Docket No.: INTEL1320-1 (P14241X)	Serial No.: 10/675,884
		Applicants: Berlin et al.	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT		Filing Date: September 29, 2003	Group Art Unit: 1743

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EXAM. INITIALS		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
Y6	AA	5,303,710	04/19/1994	Bashkansky and Reintjes			
	AB	5,306,403	04/26/1994	Tuan Vo-Dinh			
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Y6	AF	0 618 442 A1	03/23/1994	EURO			
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	AH	WO 99/44045	09/02/1999	PCT			
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	AJ	WP 03/027307	04/03/2003	PCT			

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EXAMINER	<i>John Hale</i>	DATE CONSIDERED	11/22/04
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EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

07/05/04

FORM PTO-1449 U.S. Department of Commerce Patent and Trademark Office	Docket No.: INTEL1320-1 (P14241X)	Serial No.: 10/675,884
	Applicants: Berlin, et al.	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT	Filing Date: September 29, 2003	Group Art Unit: 1743

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EXAM. INITIALS		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION (YES/NO)

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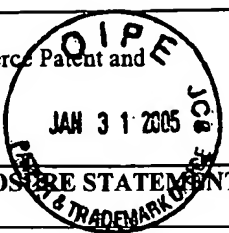
Y6	L	Doering, et al., "Spectroscopic Tags Using Dye-Embedded Nanoparticles and Surface -Enhanced Raman Scattering", <i>Analytical Chemistry</i> , :5-9
	M	Mulvaney, et al., "Glass-Coated, Analyte-Tagged Nanoparticles: A New Tagging System Based on Detection with Surface-Enhanced Raman Scattering", <i>Am Chem Soc.</i> 19:4784-4790 (2003).

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01/21/05

<b>FORM PTO-1449</b> U.S. Department of Commerce Patent and Trademark Office	<b>Docket No.:</b> INTEL1320-1 (P14241X)	<b>Serial No.:</b> 10/675,149
	<b>Applicants:</b> Berlin, et al.	
<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>	<b>Filing Date:</b> September 29, 2003	<b>Group Art Unit:</b> 1743



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EXAM. INITIALS		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB-CLASS	FILING DATE
Y6	A	5,452,084	9/19/95	Mitchell, et al.	356	301	
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copy	C	Doering, et al., "Spectroscopic Tags Using Dye Embedded Nanoparticles and Surface-Enhanced Raman Scattering", <i>Analytical Chemistry</i> , :5-9
	D	Mulvaney, et al., "Glass-Coated, Analyte-Tagged Nanoparticles: A New Tagging System Based on Detection with Surface-Enhanced Raman Scattering", <i>Am Chem Soc.</i> 19:4784-4790 (2003).

<b>EXAMINER</b> GT6432089.1 1090132-27 Melew Hah	<b>DATE CONSIDERED</b> 07/19/05
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